

CSD23203W -8V P 通道 NexFET™ 功率金属氧化物半导体场效应晶体管 (MOSFET)

1 特性

- 超低 Q_g 和 Q_{gd}
- 低导通电阻 $R_{DS(on)}$
- 小尺寸
- 低厚度, 0.62mm 高
- 无铅
- 符合 RoHS 环保标准
- 无卤素
- CSP 1mm × 1.5mm 晶圆级封装

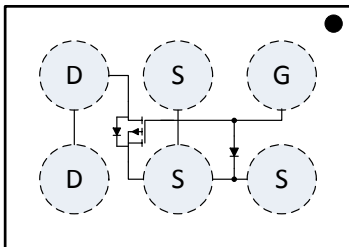
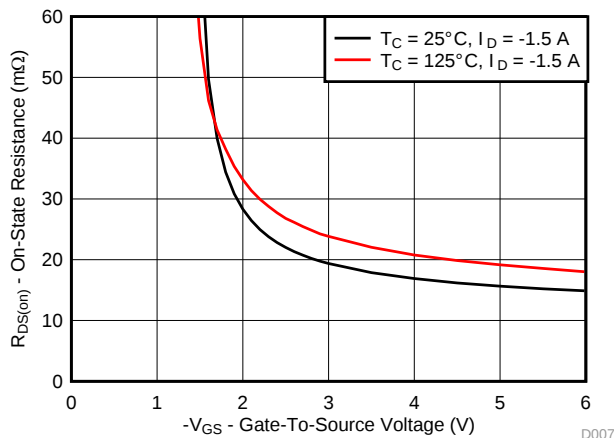
2 应用

- 电池管理
- 负载开关
- 电池保护

3 说明

这款 -8V、16.2mΩ、P 通道器件经过设计, 能够以具有出色散热特性的 1 × 1.5 mm 超薄小外形封装提供最低的导通电阻和栅极电荷。

顶视图

 $R_{DS(on)}$ 与 V_{GS} 对比

产品概要

$T_A = 25^\circ\text{C}$		典型值	单位
V_{DS}	漏源电压	-8	V
Q_g	栅极电荷总量 (-4.5V)	4.9	nC
Q_{gd}	栅极电荷 (栅极到漏极)	0.6	nC
$R_{DS(on)}$	漏源导通电阻	$V_{GS} = -1.8\text{V}$	35 mΩ
		$V_{GS} = -2.5\text{V}$	22 mΩ
		$V_{GS} = -4.5\text{V}$	16.2 mΩ
$V_{GS(th)}$	电压阈值	-0.8	V

器件信息⁽¹⁾

器件	数量	包装介质	封装	运输
CSD23203W	3000	7 英寸卷带	1.00mm × 1.50mm 晶圆级封装	卷带封装
CSD23203WT	250	7 英寸卷带		

(1) 如需了解所有可用封装, 请参阅产品说明书末尾的可订购产品附录。

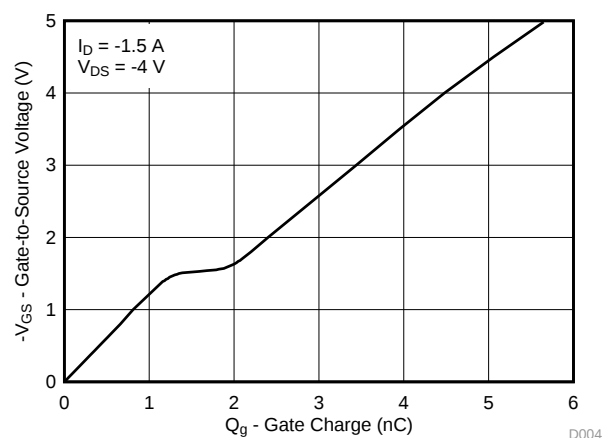
绝对最大额定值

$T_A = 25^\circ\text{C}$		值	单位
V_{DS}	漏源电压	-8	V
V_{GS}	栅源电压	-6	V
I_D	持续漏极电流 ⁽¹⁾	-3	A
I_{DM}	脉冲漏极电流 ⁽²⁾	-54	A
P_D	功率耗散	0.75	W
T_J, T_{stg}	工作结温, 储存温度	-55 至 150	°C

(1) 器件在 105°C 温度下运行。

(2) 典型 $R_{\theta JA} = 170^\circ\text{C/W}$, 脉宽 $\leq 100 \mu\text{s}$, 占空比 $\leq 1\%$ 。

栅极电荷



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4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

Changes from Original (December 2014) to Revision A	Page
• 在俯视图中更改了 MOSFET 机身连线	1
• 已添加 接收文档更新通知和社区资源部分	7

5 Specifications

5.1 Electrical Characteristics

 $T_A = 25^\circ\text{C}$ (unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC CHARACTERISTICS						
BV _{DSS}	Drain-to-source voltage	V _{GS} = 0 V, I _D = −250 μA	−8			V
I _{DSS}	Drain-to-source leakage current	V _{GS} = 0 V, V _{DS} = −6.4 V			−1	μA
I _{GSS}	Gate-to-source leakage current	V _{DS} = 0 V, V _{GS} = −6 V			−100	nA
V _{GS(th)}	Gate-to-source threshold voltage	V _{DS} = V _{GS} , I _D = −250 μA	−0.6	−0.8	−1.1	V
R _{DS(on)}	Drain-to-source on-resistance	V _{GS} = −1.8 V, I _D = −1.5 A	35		53	mΩ
		V _{GS} = −2.5 V, I _D = −1.5 A	22		26.5	mΩ
		V _{GS} = −4.5 V, I _D = −1.5 A	16.2		19.4	mΩ
g _{fs}	Transconductance	V _{DS} = −0.8 V, I _D = −1.5 A	14			S
DYNAMIC CHARACTERISTICS						
C _{ISS}	Input capacitance	V _{GS} = 0 V, V _{DS} = −4 V, f = 1 MHz	703		914	pF
C _{OSS}	Output capacitance		391		508	pF
C _{RSS}	Reverse transfer capacitance		133		172	pF
Q _g	Gate charge total (−4.5 V)	V _{DS} = −4 V, I _D = −1.5 A	4.9		6.3	nC
Q _{gd}	Gate charge gate-to-drain		0.6			nC
Q _{gs}	Gate charge gate-to-source		1.3			nC
Q _{g(th)}	Gate charge at V _{th}		0.6			nC
Q _{OSS}	Output charge	V _{DS} = −4 V, V _{GS} = 0 V	1.9			nC
t _{d(on)}	Turnon delay time	V _{DS} = −4 V, V _{GS} = −4.5 V, I _D = −1.5 A R _G = 10 Ω	14			ns
t _r	Rise time		12			ns
t _{d(off)}	Turnoff delay time		58			ns
t _f	Fall time		27			ns
DIODE CHARACTERISTICS						
V _{SD}	Diode forward voltage	I _S = −1.5 A, V _{GS} = 0 V	−0.75	−1		V
Q _{rr}	Reverse recovery charge	V _{DS} = −4.7 V, I _F = −1.5 A	6.1			nC
t _{rr}	Reverse recovery time	di/dt = 100 A/μs	21			ns

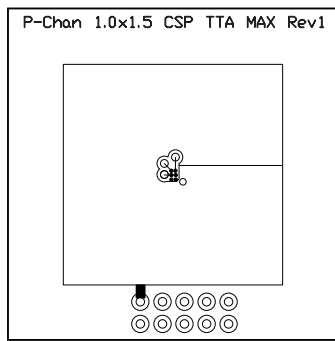
5.2 Thermal Information

 $T_A = 25^\circ\text{C}$ (unless otherwise stated)

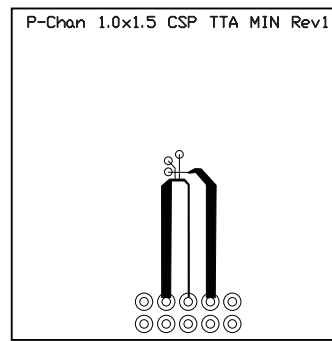
THERMAL METRIC		MIN	TYP	MAX	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance ⁽¹⁾		170		$^\circ\text{C}/\text{W}$
	Junction-to-ambient thermal resistance ⁽²⁾		55		

(1) Device mounted on FR4 material with minimum Cu mounting area.

(2) Device mounted on FR4 material with 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu.



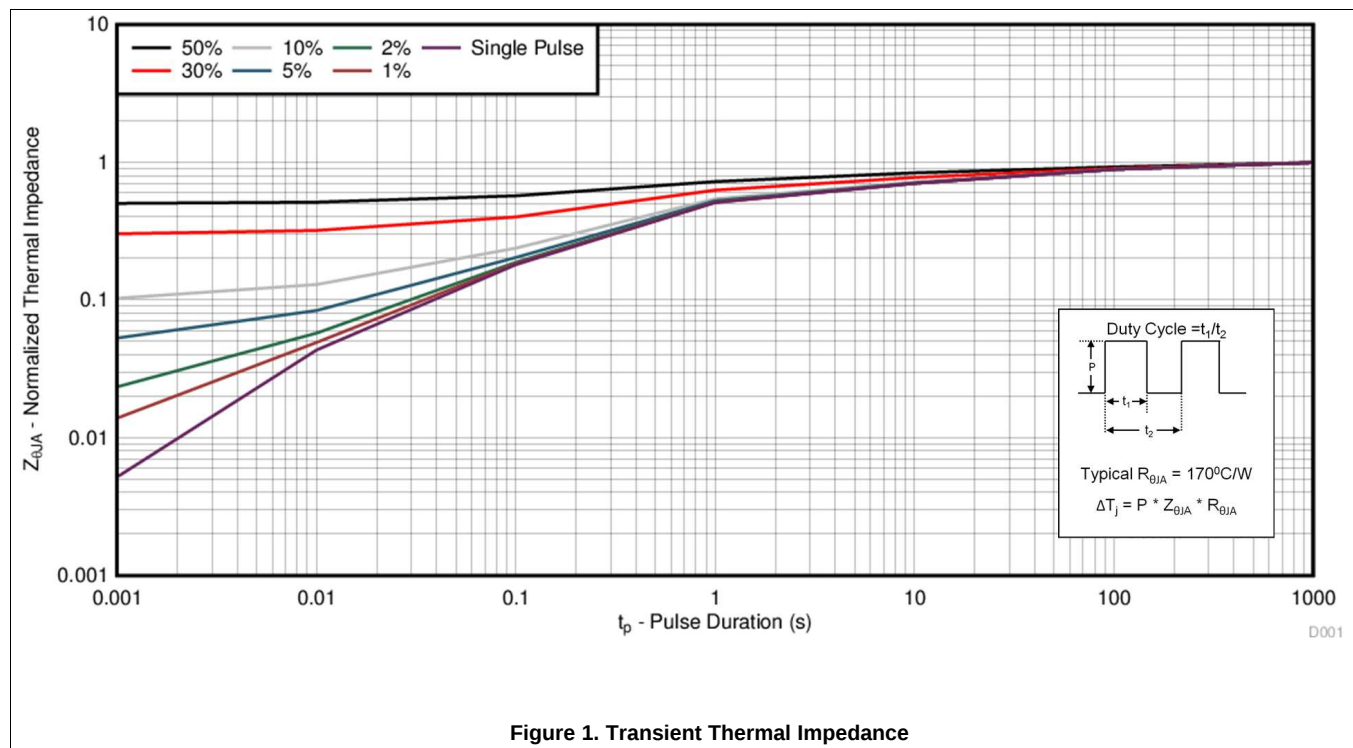
Typ $R_{\theta JA} = 55^{\circ}\text{C/W}$
when mounted on
1 in² of 2-oz Cu.



Typ $R_{\theta JA} = 170^{\circ}\text{C/W}$
when mounted on
minimum pad area of
2-oz Cu.

5.3 Typical MOSFET Characteristics

$T_A = 25^{\circ}\text{C}$ (unless otherwise stated)



Typical MOSFET Characteristics (continued)

$T_A = 25^\circ\text{C}$ (unless otherwise stated)

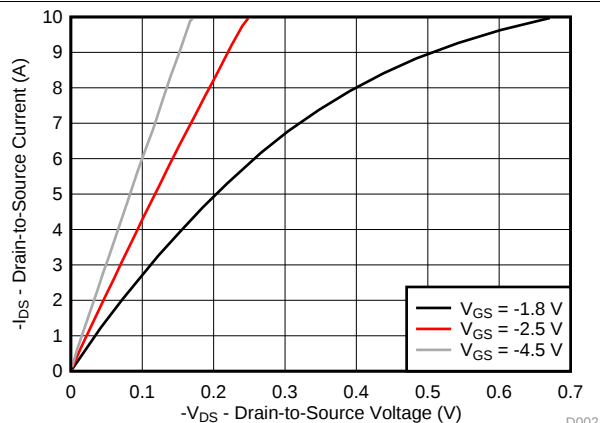


Figure 2. Saturation Characteristics

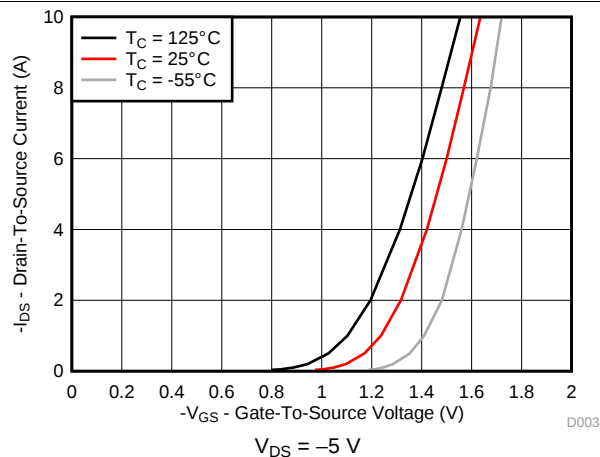


Figure 3. Transfer Characteristics

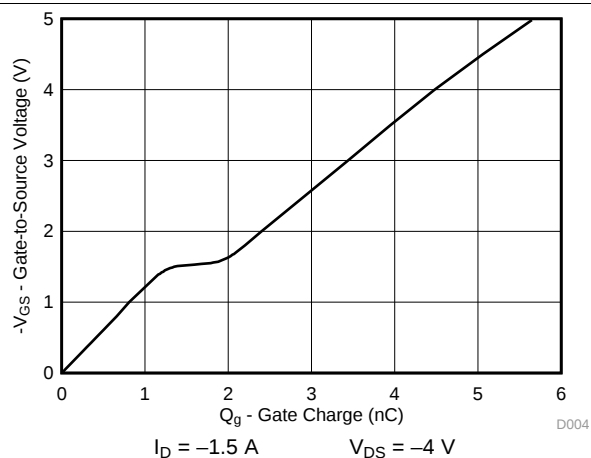


Figure 4. Gate Charge

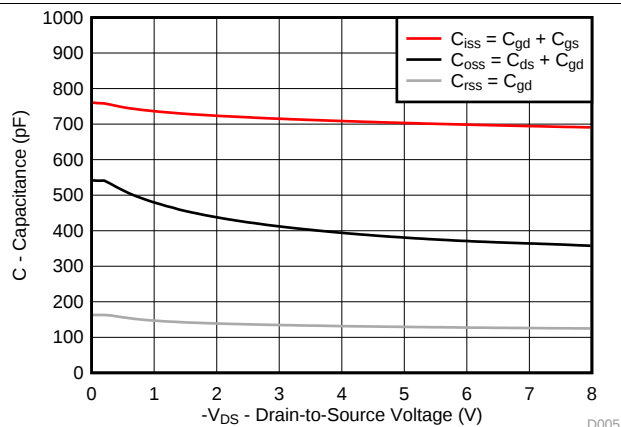


Figure 5. Capacitance

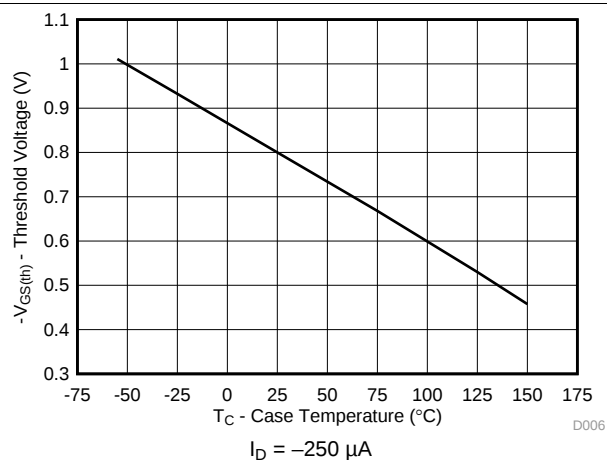


Figure 6. Threshold Voltage vs Temperature

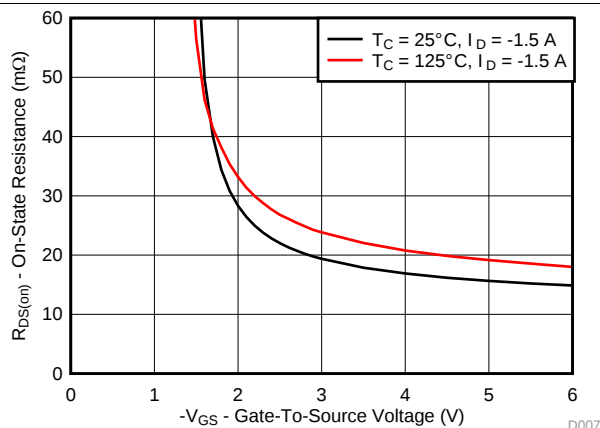


Figure 7. On-State Resistance vs Gate-to-Source Voltage

Typical MOSFET Characteristics (continued)

$T_A = 25^\circ\text{C}$ (unless otherwise stated)

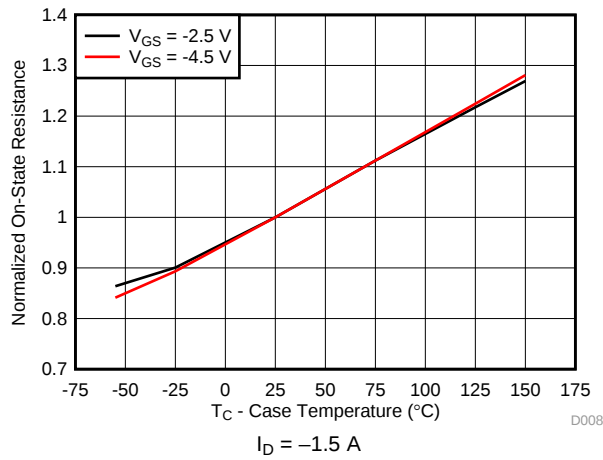


Figure 8. Normalized On-State Resistance vs Temperature

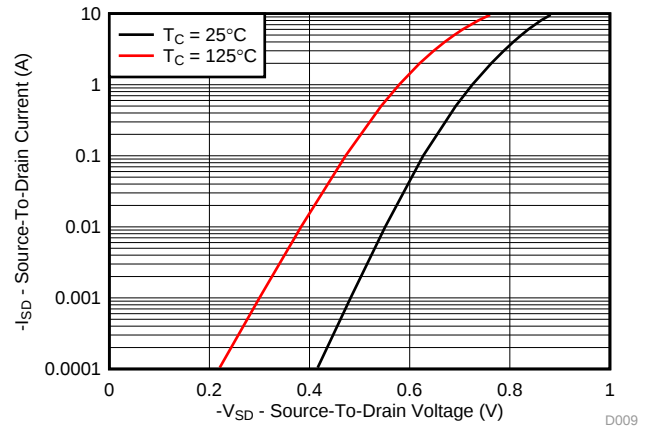


Figure 9. Typical Diode Forward Voltage

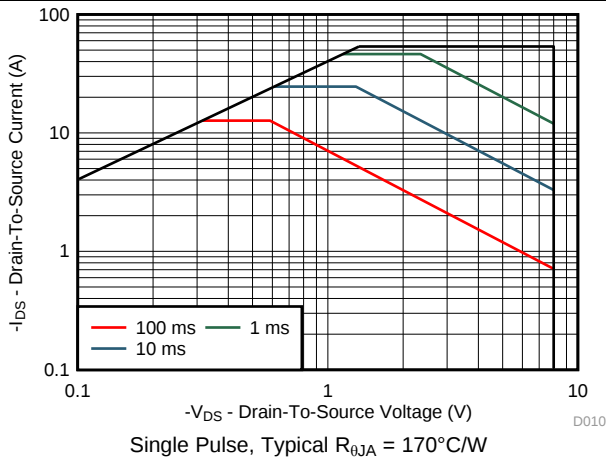


Figure 10. Maximum Safe Operating Area

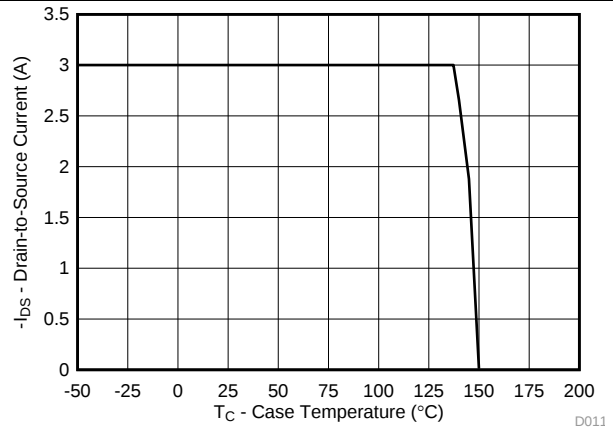


Figure 11. Maximum Drain Current vs Temperature

6 器件和文档支持

6.1 接收文档更新通知

要接收文档更新通知，请导航至德州仪器 TI.com.cn 上的器件产品文件夹。请单击右上角的通知我 进行注册，即可收到任意产品信息更改每周摘要。有关更改的详细信息，请查看任意已修订文档中包含的修订历史记录。

6.2 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

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设计支持 TI 参考设计支持 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

6.3 商标

NexFET, E2E are trademarks of Texas Instruments.
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6.4 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

6.5 Glossary

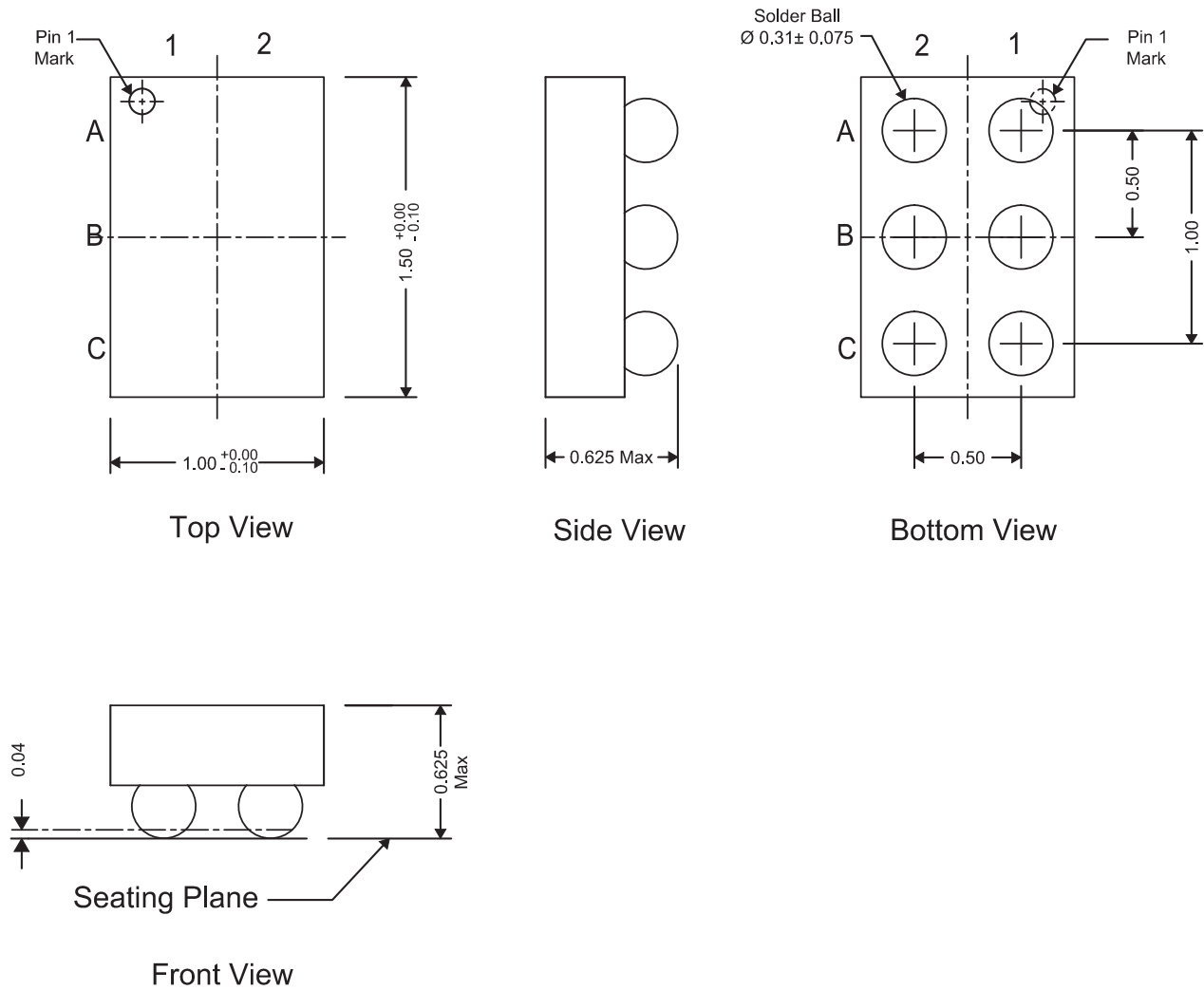
SLY0022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

7 机械、封装和可订购信息

以下页面包括机械、封装和可订购信息。这些信息是指定器件的最新可用数据。这些数据发生变化时，我们可能不会另行通知或修订此文档。如欲获取此产品说明书的浏览器版本，请参阅左侧的导航栏。

7.1 CSD23203W 封装尺寸

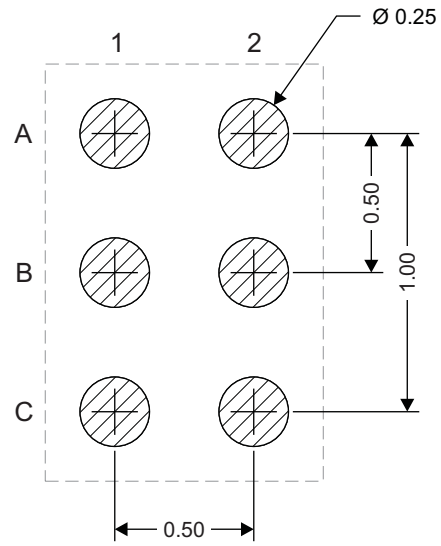


NOTE: 全部尺寸单位为 mm（除非另外注明）。

表 1. 引脚分配

位置	名称
C1, C2	漏极
A1	栅极
A2, B1, B2	源极

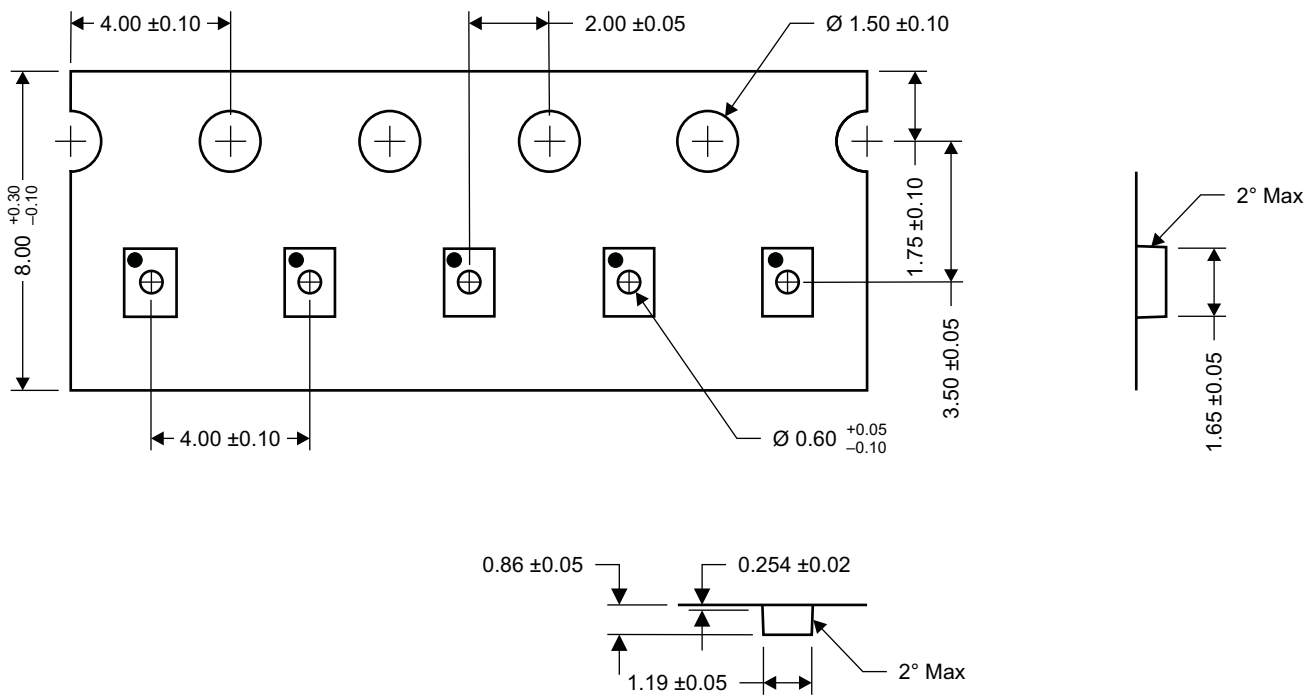
7.2 焊盘布局建议



M0158-01

NOTE: 全部尺寸单位为 mm（除非另外注明）。

7.3 卷带封装信息



M0159-01

NOTE: 全部尺寸单位为 mm（除非另外注明）。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CSD23203W	ACTIVE	DSBGA	YZC	6	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM		23203	Samples
CSD23203WT	ACTIVE	DSBGA	YZC	6	250	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-55 to 150	23203	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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